

<b>Notice of References Cited</b>		Application/Control No. 10/596,880	Applicant(s)/Patent Under Reexamination KANEKIYO ET AL.	
		Examiner John P. Sheehan	Art Unit 1793	Page 1 of 1

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*	B	US-2004/0099346 A1	05-2004	Nishiuchi et al.	148/302
*	C	US-2004/0051614 A1	03-2004	Kanekiyo et al.	335/302
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#### NON-PATENT DOCUMENTS

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